

Search Notes

Application/Control No.

08/990,096

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

PICHER-DEMPSEY, HEIDI

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
709	223	5/10/2007	HN
	224		
	203		
	218		
	219		
	220		
	225		
370	351		
370	352		
370	230		
	230.1		
	231		
	468		
370	395.41		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	468	5/10/2007	HN
	352		
709	2254		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	5/10/2007	HN